### **Features**

- Ultra-low Q<sub>G</sub> For High Efficiency
- Logic Level
- Light Weight
- No Wire Bond for Higher Reliability and Low Inductance
- Total Ionizing Dose LDR Immune
- Total Ionizing Dose HDR Immune
- Single Event Effect (SEE) Hardened
  - SEE immunity for LET of 84 MeV/(mg/cm²) with V<sub>DS</sub> up to 100% of rated Breakdown
- Neutron
  - Maintains Pre-Rad specification for up to 4 x 10<sup>15</sup> Neutrons/cm<sup>2</sup>

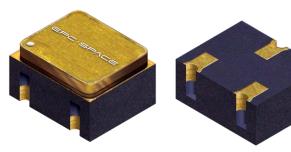
## **Application**

- Commercial Satellite EPS & Avionics
- Deep Space Probes
- High Speed Rad-Hard DC-DC Conversion
- Rad-Hard Motor Controllers
- Nuclear Facilities

#### **Thermal Characteristics**

| Symbol          | Parameter-Conditions                            | Value | Units |
|-----------------|---|-------|-------|
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient (Note 3) | 200   | °C/W  |
| $R_{\theta JC}$ | Thermal Resistance Junction to Case             | 35    | G/VV  |





## EPC7014UBC

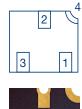
Rad-Hard eGaN<sup>®</sup> 60 V, 1 A, 580 mΩ Surface Mount (UB)

### **Description**

EPC Space Rad-Hard eGaN® power switching HEMTs have been specifically designed for critical applications in Space and other the high reliability environments. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low  $R_{\rm DS(on)}$  values. The lateral structure of the die provides for very low gate charge ( $Q_{\rm G}$ ) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

### I/O Pin Assignment (Bottom View)

| Pin | Symbol | Description        |
|-----|--------|--------------------|
| 1   | G      | Gate               |
| 2   | D      | Drain              |
| 3   | S      | Source             |
| 4   | L      | Lid Pad Connection |





### **Absolute Maximum Rating** (T<sub>C</sub> = 25°C unless otherwise noted)

| Symbol           | Parameter-Conditions   | Value                  | Units |  |  |
|------------------|--|------------------------|-------|--|--|
| V                | Drain to Source Voltage (Note 1)   | 60                     | V     |  |  |
| $V_{DS}$         | Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)                | ns pulses at 150°C) 72 |       |  |  |
| I <sub>D</sub>   | Continuous Drain Current ID @ V <sub>GS</sub> = 5 V, T <sub>C</sub> = 25°C | 1                      | ^     |  |  |
| I <sub>DM</sub>  | Single-Pulse Drain Current t <sub>pulse</sub> ≤ 80 µs                      | 4                      | А     |  |  |
| V <sub>GS</sub>  | Gate to Source Voltage (Note 2)  | +6 / -4                | V     |  |  |
| $T_J, T_{STG}$   | T <sub>STG</sub> Operating and Storage Junction Temperature Range          |                        | °C    |  |  |
| T <sub>sol</sub> | Package Mounting Surface Temperature                                       | 260                    | C     |  |  |
| ESD              | ESD Class  | 1A(ΔA)                 |       |  |  |
| Weight           | Device Weight  | 0.058                  | g     |  |  |



## Electrical Characteristics ( $T_C = 25$ °C unless otherwise noted. Typical (TYP) values are for reference only.)

| Parameter   | Symbol                       | Test Conditions                            |                                | MIN | TYP  | MAX | Units |
|---|------------------------------|--|--------------------------------|-----|------|-----|-------|
| Drain to Source Voltage                                     | B <sub>VDSS</sub>            | $V_{GS} = 0 V$                             |                                | 60  |      |     | V     |
| Drain to Source Leakage                                     |                              | V <sub>DS</sub> = 60 V                     | $T_C = 25^{\circ}C$            |     | 0.17 | 100 |       |
| Drain to Source Leakage                                     | I <sub>DSS</sub>             | $V_{GS} = 0 V$                             | T <sub>C</sub> = 125°C         |     | 0.35 | 180 |       |
| Gate to Source Forward Leakage                              | I <sub>GSSF</sub>            | $V_{GS} = 5 \text{ V}$                     | T <sub>C</sub> = 25°C          |     | 2    | 500 | μA    |
| Gate to Source Reverse Leakage                              | I <sub>GSSR</sub>            | $V_{GS} = -3 \text{ V}$                    | T <sub>C</sub> = 25°C          |     | 0.27 | 100 |       |
| Gate to Source Threshold Voltage                            | V <sub>GS(th)</sub>          | $V_{DS} = V_{GS}, I_{D} = 0.14 \text{ mA}$ | T <sub>C</sub> = 25°C          | 0.8 | 1.8  | 2.5 | V     |
| Gate to Source Threshold Voltage<br>Temperature Coefficient | $\Delta V_{GS(th)}/\Delta T$ | $V_{DS} = V_{GS}, I_{D} = 0.14 \text{ mA}$ | -55°C < T <sub>A</sub> < 150°C |     | 2.34 |     | mV/°C |
| Drain to Source Resistance (Note 4)                         | R <sub>DS(on)</sub>          | $I_D = 1 A, V_{GS} = 5 V$                  | T <sub>C</sub> = 25°C          |     | 340  | 580 | mΩ    |
| Source to Drain Forward Voltage                             | V <sub>SD</sub>              | $I_S = 0.5 \text{ A}, V_G = 0 \text{ V}$   | T <sub>C</sub> = 25°C          |     | 2.5  | 3   | V     |

## $\textbf{Dynamic Characteristics} \ (T_{\text{C}} = 25^{\circ}\text{C unless otherwise noted. Typical (TYP) values are for reference only.)}$

| Parameter                                | Symbol           | Test Conditions                                    | MIN | TYP  | MAX  | Units |
|--|------------------|--|-----|------|------|-------|
| Input Capacitance                        | C <sub>ISS</sub> |  |     | 18   | 22   |       |
| Output Capacitance                       | C <sub>OSS</sub> | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$      |     | 17   | 30   | pF    |
| Reverse transfer Capacitance             | C <sub>RSS</sub> |  |     | 0.1  | 2    |       |
| Gate Resistance (Note 5)                 | $R_{G}$          | $f = 1 \text{ MHz}, V_{DS} = V_{GS} = 0 \text{ V}$ |     | 12.6 |      | Ω     |
| Total Gate Charge (Note 6)               | $Q_{G}$          |  |     | 142  | 184  |       |
| Gate to Source Charge (Note 6)           | Q <sub>GS</sub>  | $V_{DS} = 30 \text{ V}, I_{D} = 0.5 \text{ A}$     |     | 20   | 35   | рC    |
| Gate to Drain Charge (Note 6)            | Q <sub>GD</sub>  |  |     | 30   | 50   |       |
| Output Charge (Note 5)                   | Q <sub>OSS</sub> | $V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}$      |     | 764  | 1145 |       |
| Source to Drain Recovery Charge (Note 5) | Q <sub>RR</sub>  | $I_D = 1 \text{ A}, V_{DS} = 30 \text{ V}$         |     | 0    |      |       |

Figure 1: Typical Gate-Source Leakage Current vs. Ambient Temp.

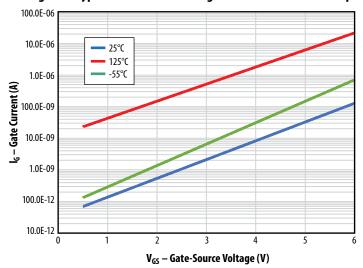


Figure 2: Typical Drain-Source Leakage Current vs. Ambient Temp.

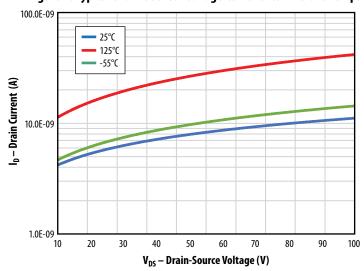


Figure 3: Typical Output Characteristics at 25°C

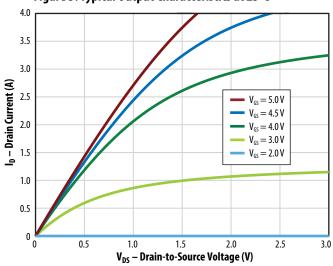
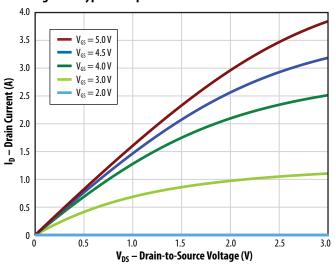
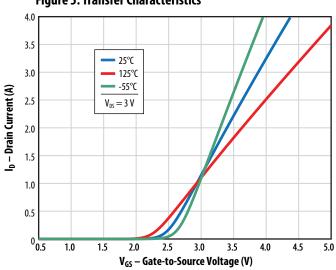


Figure 4: Typical Output Characteristics at 25°C



**Figure 5: Transfer Characteristics** 



**Figure 6: Reverse Drain-Source Characteristics** 

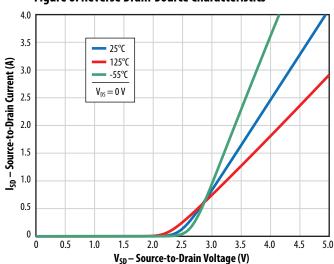
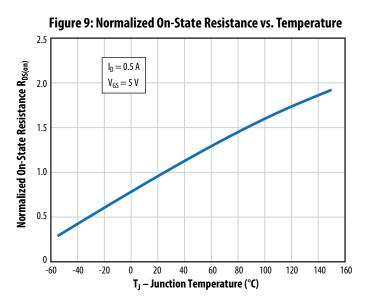
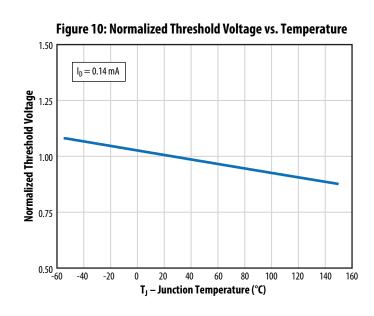
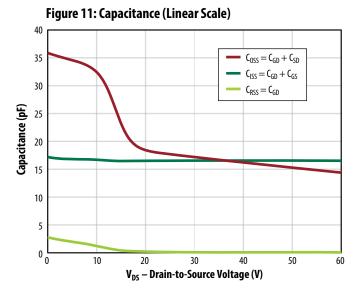


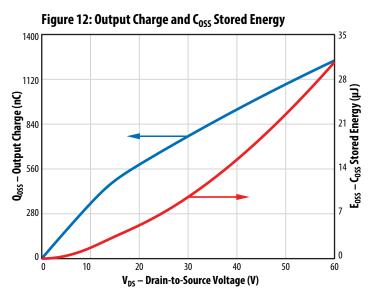
Figure 7: R<sub>DS(on)</sub> vs. V<sub>GS</sub> for Various Drain Currents  $R_{\text{DS}(\text{on})}-$  Drain-to-Source Resistance (m $\Omega)$  $I_D = 0.2 A$  $I_D = 0.5 A$ 800  $I_D\,{=}\,0.8\,A$  $I_{D} = 1.0 A$ 600 400 200 4.0 3.0 3.5 4.5 5.0 V<sub>GS</sub> – Gate-to-Source Voltage (V)

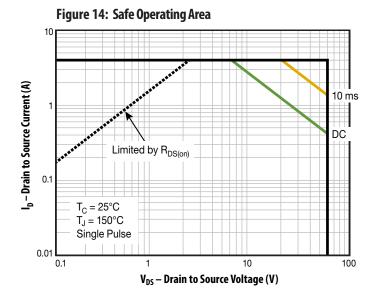
Figure 8: R<sub>DS(on)</sub> vs. V<sub>GS</sub> for Various Temperatures 1000 — 25°C **−** 125°C  $R_{DS(on)}-$  Drain-to-Source Resistance (m $\Omega)$ 800 — -55°C  $V_{DS} = 0.14 \text{ V}$ 600 200 0 2.0 2.5 3.5 4.5 5.0 V<sub>GS</sub> – Gate-to-Source Voltage (V)



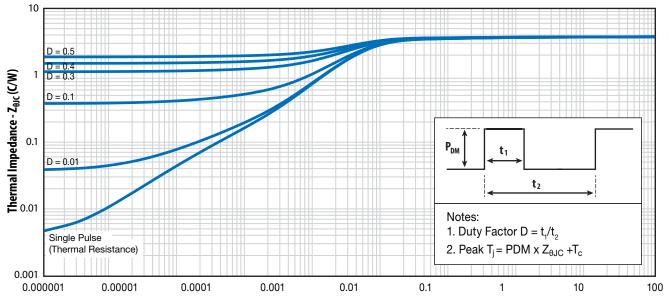








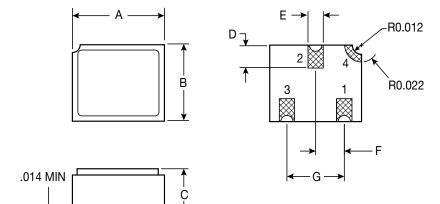




t<sub>1</sub>, Rectangular Pulse Duration (Sec)



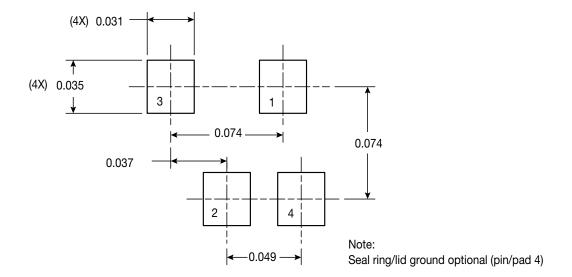
## **Package Outline and Dimensions**



| Symbol | Inch  | nes   | Millimeters |       |  |
|--------|-------|-------|-------------|-------|--|
|        | MIN   | MAX   | MIN         | MAX   |  |
| Α      | 0.115 | 0.128 | 2.921       | 3.251 |  |
| В      | 0.095 | 0.108 | 2.413       | 2.743 |  |
| С      | 0.064 | 0.082 | 1.625       | 2.083 |  |
| D      | 0.024 | 0.036 | 0.610       | 0.910 |  |
| E      | 0.016 | 0.024 | 0.410       | 0.610 |  |
| F      | 0.035 | 0.039 | 0.889       | 0.991 |  |
| G      | 0.071 | 0.079 | 1.803       | 2.006 |  |

Standard Terminal Pad finish is a solder alloy of 63%Sn 37%Pb.

# **UB Footprint for Printed Circuit Board Design**





#### **Notes**

- Note 1. Never exceed the absolute maximum V<sub>DS</sub> of the device otherwise permanent damage/destruction may result.
- Note 2. Never exceed the absolute maximum  $V_{GS}$  of the device otherwise permanent damage/destruction may result. We recommend a  $V_{GS}$  of 5V for optimum operation across life and radiation.
- Note 3. R<sub>0JA</sub> measured with LCC3 package mounted to double-sided PCB, 0.063" thickness with 1.0 square inches of copper area on the top (mounting side) and a flood etch (3 square inches) on the bottom side.
- Note 4. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80 µs and duty cycle is 1%, maximum.
- Note 5. Guaranteed by design/device construction. Not tested.
- Note 6. The gate charge parameters are measured based on the MIL-STD-750.3471 Condition B. A high speed constant gate current ( $I_{const}$ ) is provided to the Gate of the DUT during the time that the ground switch ( $G_S$ ) is OFF ( $t_{off}$ ). The DUT is switched ON and OFF using ground-sensed switch  $G_S$ . The gate current is adjusted to yield the desired charge per unit time ( $I_{const}$  · time per division) on the measuring oscilloscope. The  $G_S$  pulse drive ON time ( $t_{on}$ ) is adjusted for the desired observability of the gate-source voltage ( $V_{GS}$ ) waveform. The maximum duty cycle of the ground switch ( $t_{off}$  / $t_{on}$ ) should be set to 1% maximum. Please note that all gate-related signals are referenced to the "Source Sense" pin on the package. At all times during the measurement, the maximum gate-source voltage is clamped to 5  $V_{DC}$ .



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